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## LED ARRAY



Lead-Free Parts

**LA93B-5/Y2G2I-PF**

## DATA SHEET

DOC. NO : QW0905-LA93B-5/Y2G2I-PF

REV. : A

DATE : 19 - Jan. - 2006



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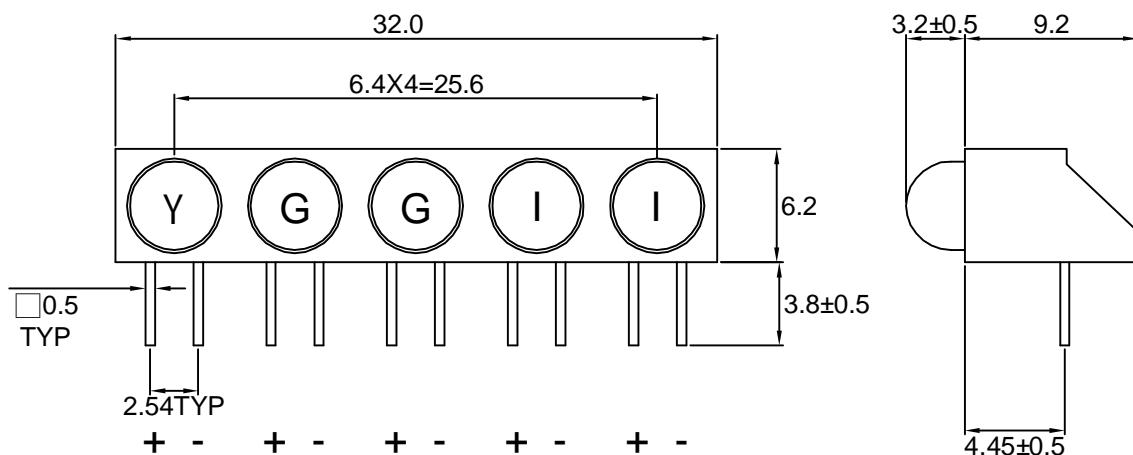
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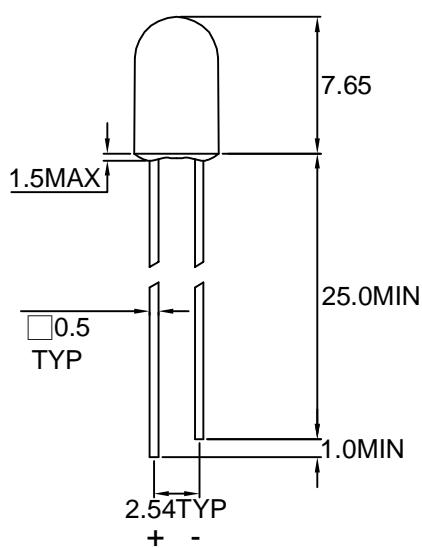
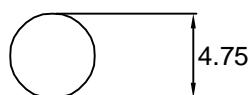
## Package Dimensions



LY3130-PF

LG3130-PF

LI3130-PF



Note : 1.All dimension are in millimeter tolerance is  $\pm 0.25\text{mm}$  unless otherwise noted.

2.Specifications are subject to change without notice.



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## Absolute Maximum Ratings at Ta=25 °C

| Parameter                            | Symbol           | Ratings    |     |     | UNIT |
|--------------------------------------|------------------|------------|-----|-----|------|
|                                      |                  | Y          | G   | I   |      |
| Forward Current                      | I <sub>F</sub>   | 20         | 30  | 30  | mA   |
| Peak Forward Current Duty 1/10@10KHz | I <sub>FP</sub>  | 80         | 120 | 120 | mA   |
| Power Dissipation                    | P <sub>D</sub>   | 60         | 100 | 100 | mW   |
| Reverse Current @5V                  | I <sub>r</sub>   | 10         |     |     | μA   |
| Operating Temperature                | T <sub>opr</sub> | -40 ~ +85  |     |     | °C   |
| Storage Temperature                  | T <sub>stg</sub> | -40 ~ +100 |     |     | °C   |

## Typical Electrical &amp; Optical Characteristics (Ta=25 °C)

| PART NO          | MATERIAL  | COLOR   |                 | Peak wave length<br>λ Pnm | Spectral halfwidth<br>△ λ nm | Forward voltage<br>@20mA(V) |      | Luminous intensity<br>@10mA(mcd) |      | Viewing angle<br>2θ 1/2<br>(deg) |
|------------------|-----------|---------|-----------------|---------------------------|------------------------------|-----------------------------|------|----------------------------------|------|----------------------------------|
|                  |           | Emitted | Lens            |                           |                              | Min.                        | Max. | Min.                             | Typ. |                                  |
| LA93B-5/Y2G2I-PF | GaAsP/GaP | Yellow  | Yellow Diffused | 585                       | 35                           | 1.7                         | 2.6  | 20                               | 30   | 46                               |
|                  | GaP       | Green   | Green Diffused  | 565                       | 30                           | 1.7                         | 2.6  | 20                               | 30   | 46                               |
|                  | GaAsP/GaP | Orange  | Red Diffused    | 635                       | 45                           | 1.7                         | 2.6  | 20                               | 30   | 46                               |

Note : 1.The forward voltage data did not including ±0.1V testing tolerance.  
 2. The luminous intensity data did not including ±15% testing tolerance.



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## Typical Electro-Optical Characteristics Curve

Y CHIP

Fig.1 Forward current vs. Forward Voltage

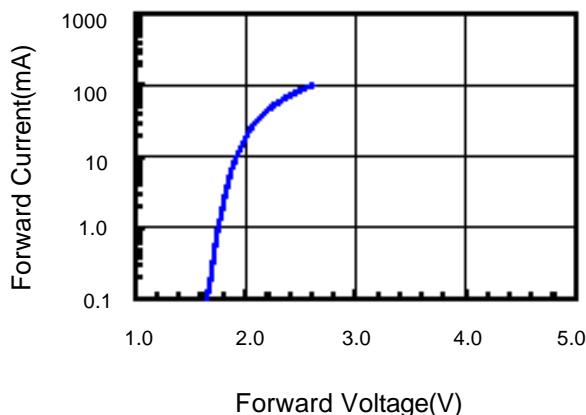


Fig.2 Relative Intensity vs. Forward Current

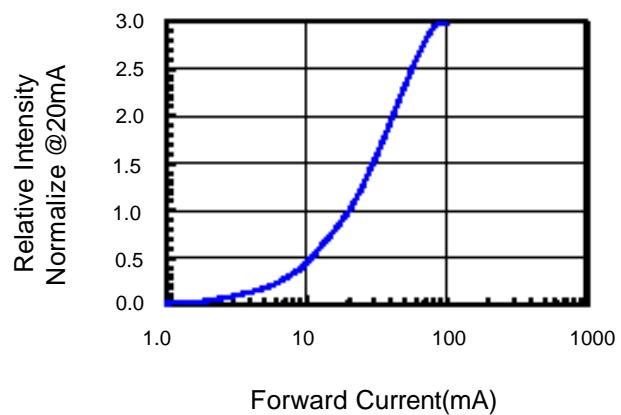


Fig.3 Forward Voltage vs. Temperature

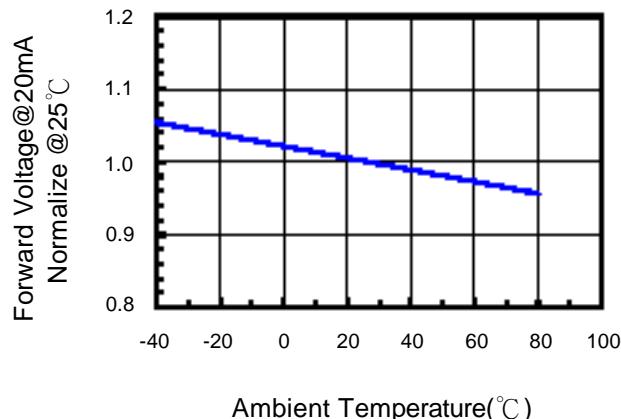


Fig.4 Relative Intensity vs. Temperature

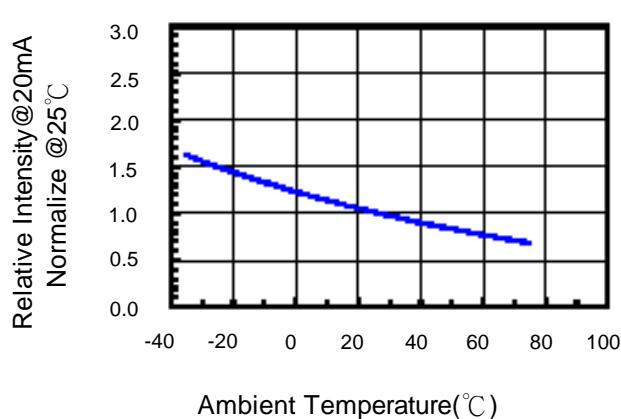
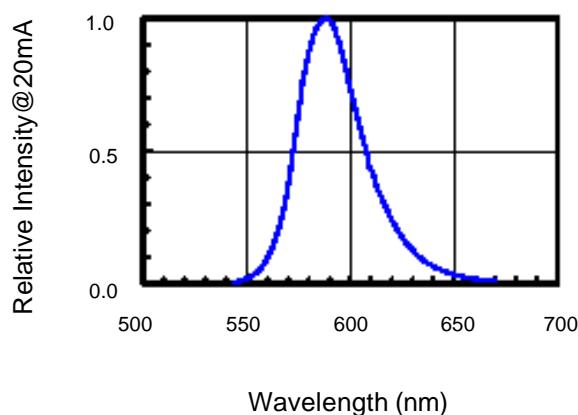


Fig.5 Relative Intensity vs. Wavelength





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## Typical Electro-Optical Characteristics Curve

G CHIP

Fig.1 Forward current vs. Forward Voltage

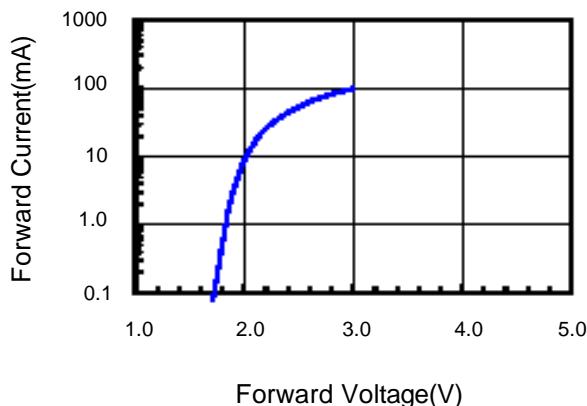


Fig.2 Relative Intensity vs. Forward Current

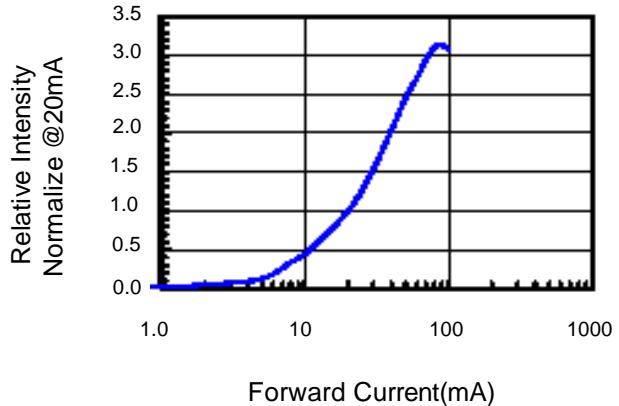


Fig.3 Forward Voltage vs. Temperature

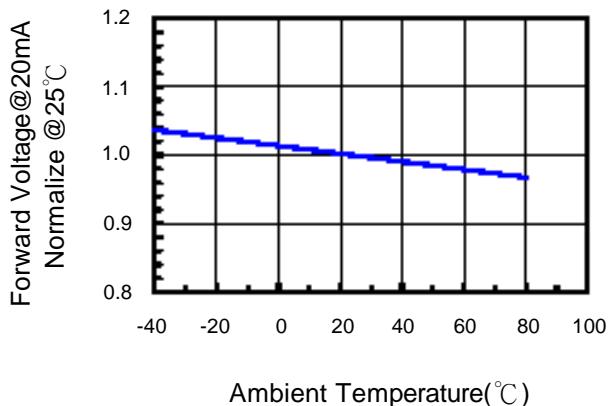


Fig.4 Relative Intensity vs. Temperature

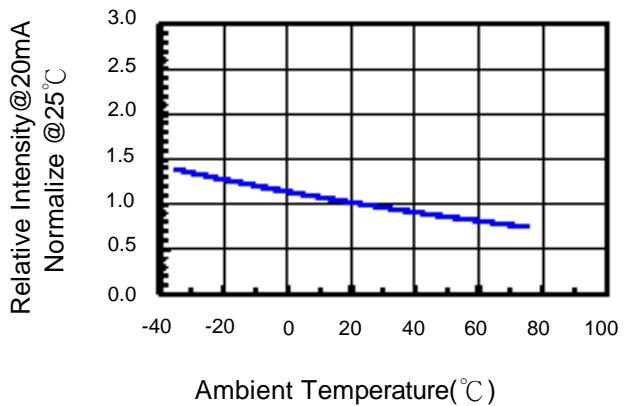
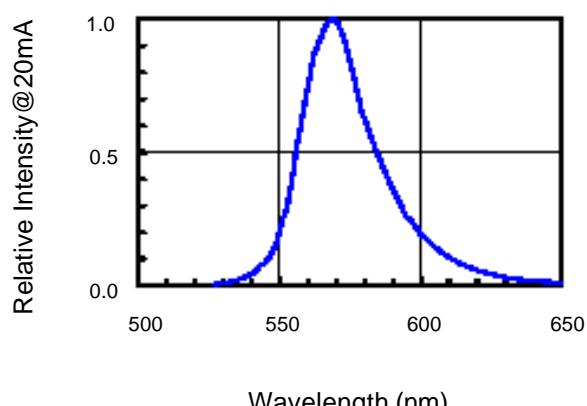


Fig.5 Relative Intensity vs. Wavelength





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## Typical Electro-Optical Characteristics Curve

E CHIP 封紅膠

Fig.1 Forward current vs. Forward Voltage

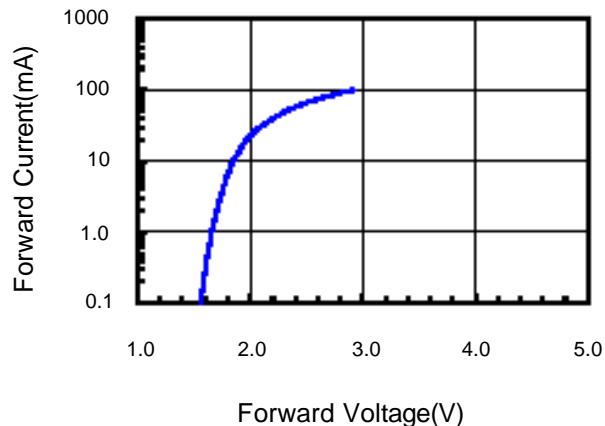


Fig.2 Relative Intensity vs. Forward Current

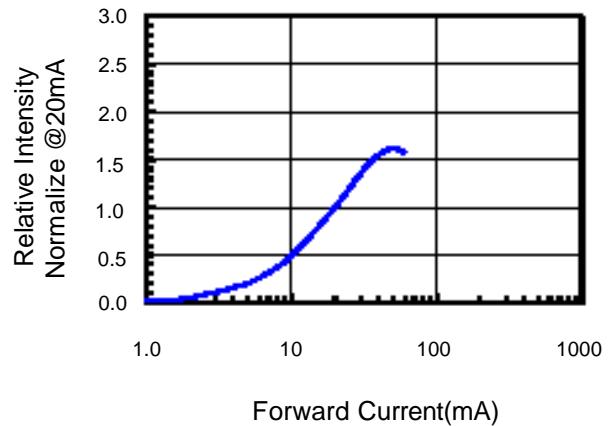


Fig.3 Forward Voltage vs. Temperature

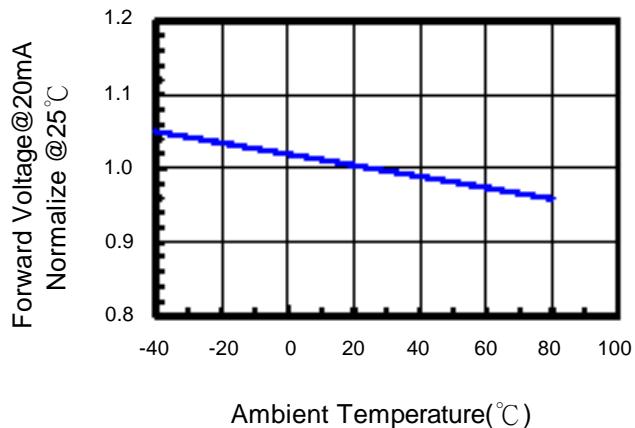


Fig.4 Relative Intensity vs. Temperature

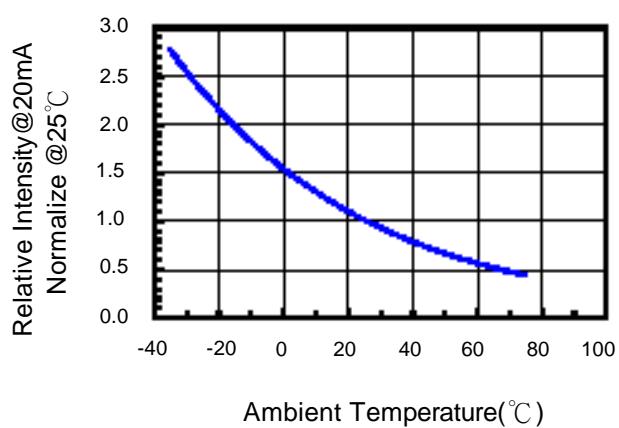
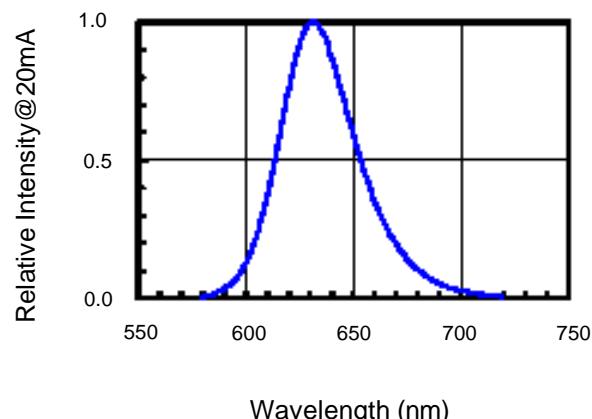


Fig.5 Relative Intensity vs. Wavelength





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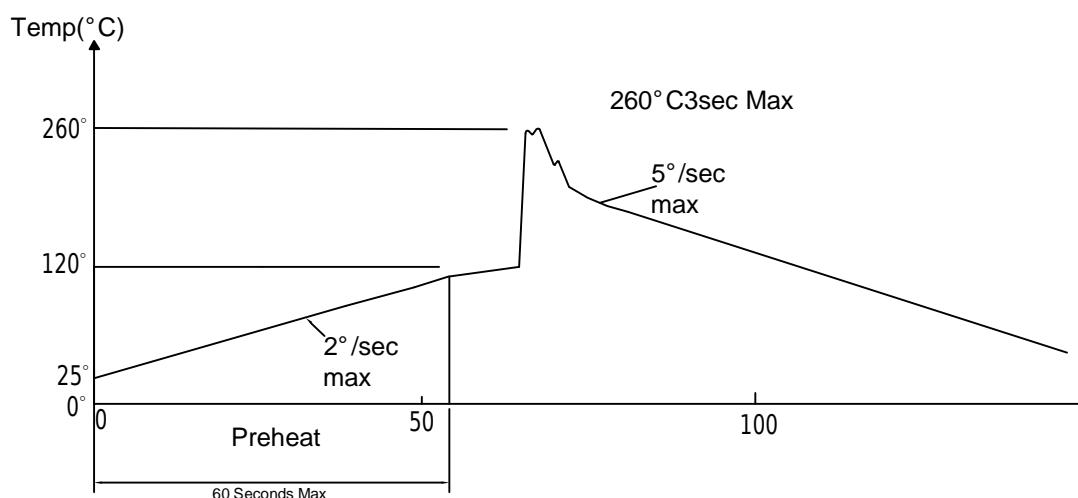
## Soldering Condition(Pb-Free)

### 1.Iron:

Soldering Iron:30W Max  
Temperature 350°C Max  
Soldering Time:3 Seconds Max(One Time)  
Distance:2mm Min(From solder joint to case)

### 2.Wave Soldering Profile

Dip Soldering  
Preheat: 120°C Max  
Preheat time: 60seconds Max  
Ramp-up  
2°C/sec(max)  
Ramp-Down:-5°C/sec(max)  
Solder Bath:260°C Max  
Dipping Time:3 seconds Max  
Distance:2mm Min(From solder joint to case)





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## Reliability Test:

| Test Item                           | Test Condition   | Description   | Reference Standard   |
|-------------------------------------|--|---|--|
| Operating Life Test                 | 1.Under Room Temperature<br>2.If=20mA<br>3.t=1000 hrs (-24hrs, +72hrs) | This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.  | MIL-STD-750: 1026<br>MIL-STD-883: 1005<br>JIS C 7021: B-1                      |
| High Temperature Storage Test       | 1.Ta=105 °C±5°C<br>2.t=1000 hrs (-24hrs, +72hrs)                       | The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.  | MIL-STD-883:1008<br>JIS C 7021: B-10   |
| Low Temperature Storage Test        | 1.Ta=-40 °C±5°C<br>2.t=1000 hrs (-24hrs, +72hrs)                       | The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.   | JIS C 7021: B-12   |
| High Temperature High Humidity Test | 1.Ta=65 °C±5°C<br>2.RH=90%~95%<br>3.t=240hrs ±2hrs                     | The purpose of this test is the resistance of the device under tropical for hours.  | MIL-STD-202:103B<br>JIS C 7021: B-11   |
| Thermal Shock Test                  | 1.Ta=105 °C±5°C &-40 °C±5°C (10min) (10min)<br>2.total 10 cycles       | The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.  | MIL-STD-202: 107D<br>MIL-STD-750: 1051<br>MIL-STD-883: 1011                    |
| Solder Resistance Test              | 1.T.Sol=260 °C±5°C<br>2.Dwell time= 10 ±1sec.                          | This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire. | MIL-STD-202: 210A<br>MIL-STD-750: 2031<br>JIS C 7021: A-1                      |
| Solderability Test                  | 1.T.Sol=230 °C±5°C<br>2.Dwell time=5 ±1sec                             | This test intended to see soldering well performed or not.  | MIL-STD-202: 208D<br>MIL-STD-750: 2026<br>MIL-STD-883: 2003<br>JIS C 7021: A-2 |